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Application/Control No.	Applicant(s)/Patent under Reexamination
10/774,212	HSIEH ET AL.
Examiner	Art Unit

Matthew E. Warren

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	SEARCHED			
Class	Subclass	Date	Examiner	
257	329-331 333*, 335 E29.262- 265	4/20/2005	MEW	
257	E29.257	4/20/2005	MEW	
438	259, 270	4/23/2005	MEW	
438	271, 589	4/23/2005	MEW	
Search	Updated	10/25/2005	MEW	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	329, 333	10/25/2005	MEW
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
Text Search	4/21/2005	MEW
Text Search Updated	10/25/2005	MEVV
		